

Notice of References Cited		Application/Control No. 10/544,227	Applicant(s)/Patent Under Reexamination TERUI ET AL.	
		Examiner KALLAMBELLA VIJAYAKUMAR	Art Unit 1793	Page 1 of 1

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*	B	US-5,733,688	03-1998	Kato et al.	430/5
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	W	Bhavani et al, "Effect of an electric field on the oxidation of aluminum at room temperature," Bull. Mater. Sci., 1980, V.2, No.4, PP 265-270.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.